


<b>Search Notes</b>  	<b>Application/Control No.</b>  10594339	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAMURA ET AL.
	<b>Examiner</b>  SHERIDAN SWOPE	<b>Art Unit</b>  1652

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Applicants	8/18/08	SLS
Priority documents	"	"
SID 6	"	"
STN, EAST, ENTREZ; enclosed	"	"
Applicants	3/3/09	SLS
Priority documents	"	"
Nakamura et al, 2000	8/4/09	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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